ATTY DOCKET NO. 3308

made of a second insulated material, a floating gate aligned to the select gate, a third insulated material disposed over the tunnel oxide layer, the select gate and the floating gate, and a control gate formed on the third insulated material."

In The Claims

Please amend Claim 11 as follows:

11. A structure of an Electrically Erasable Programmable Read-Only Memory

(EPROM), comprising:

a silicon substrate having a source/drain region;

a tunnel oxide layer disposed over said silicone substrate;

a select gate disposed over said tunnel oxide layer, wherein said select gate is defined by a conductive layer covered with a first insulated material thereon and comprises a sidewall made of a second insulated material;

a floating gate aligned to one side of said select gate;

a third insulated material/disposed over said tunnel oxide layer, said select gate and said floating gate; and

a control gate formed on said third insulated material.